## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

re Application of: DALE HARRISON

Filed:

**SEPTEMBER 23, 2003** 

For:

VACUUM ULTRAVIOLET REFLECTOMETER SYSTEM AND

**METHOD** 

Serial No.:

10/668,642

Group Art Unit:

2878

Examiner:

HANNAHER, C.

Atty Dkt:

**METR:003** 

## **EXPRESS MAIL CERTIFICATION**

NUMBER: EV758264875US

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ATTN: OFFICIAL DRAFTSMAN

**Commissioner For Patents** 

P.O. Box 1450

Alexandria, VA 22313-1450

Dear Sir:

## **REQUEST FOR CORRECTION OF DRAWINGS**

Please correct FIGS. 18, 19, 20, 21, 22, 24, 25 and 30 of the application drawings as indicated in red ink on the enclosed photocopy.

Respectfully submitted,

Registration No. 36,788 Attorney for Applicant

O'KEEFE, EGAN & PETERMAN, LLP 1101 Capital of Texas Highway South Building C, Suite 200 Austin, Texas 78746



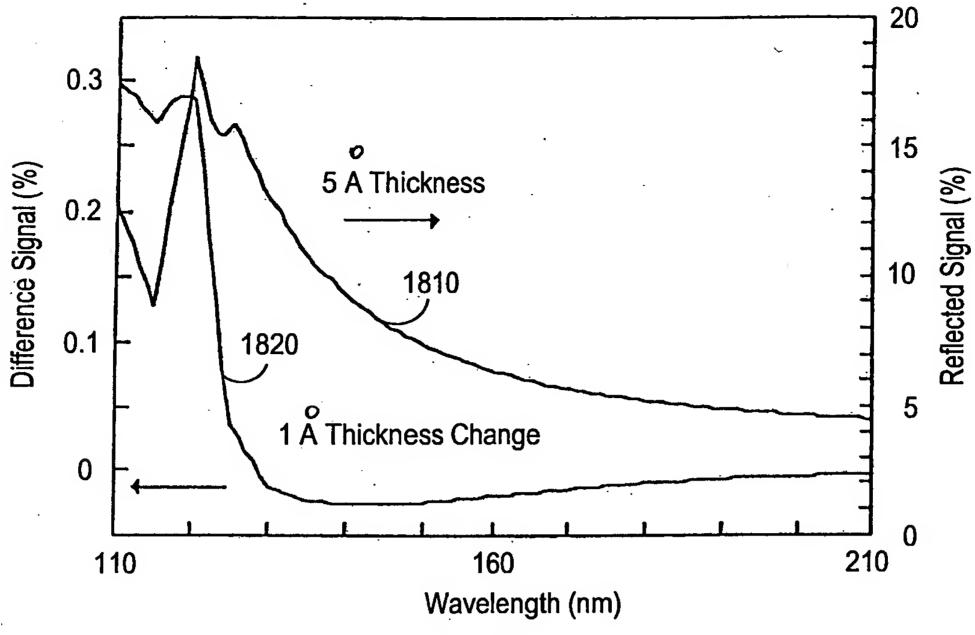
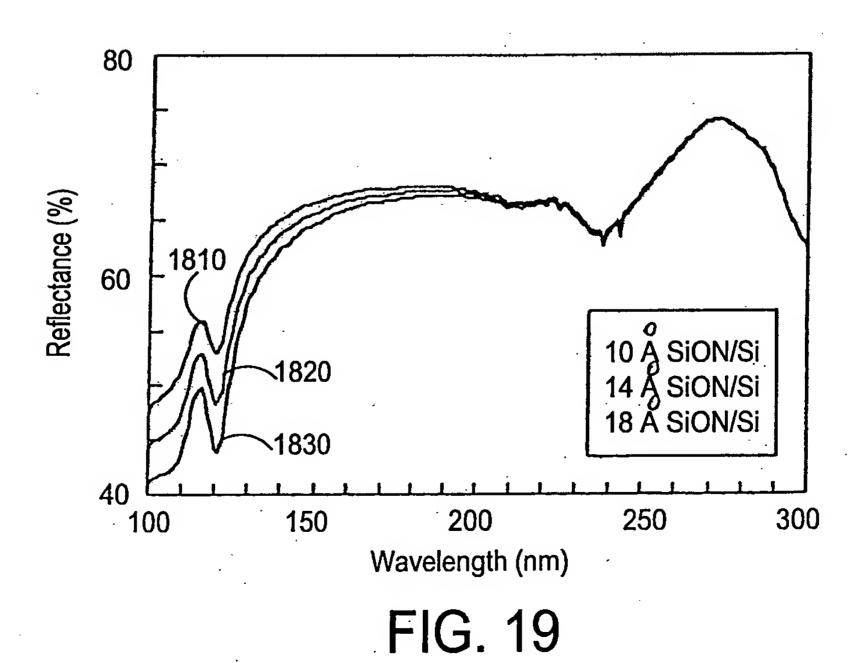


FIG. 18



13% N Layer Nitrided Oxide

Thickness Matrix (10-18 A)

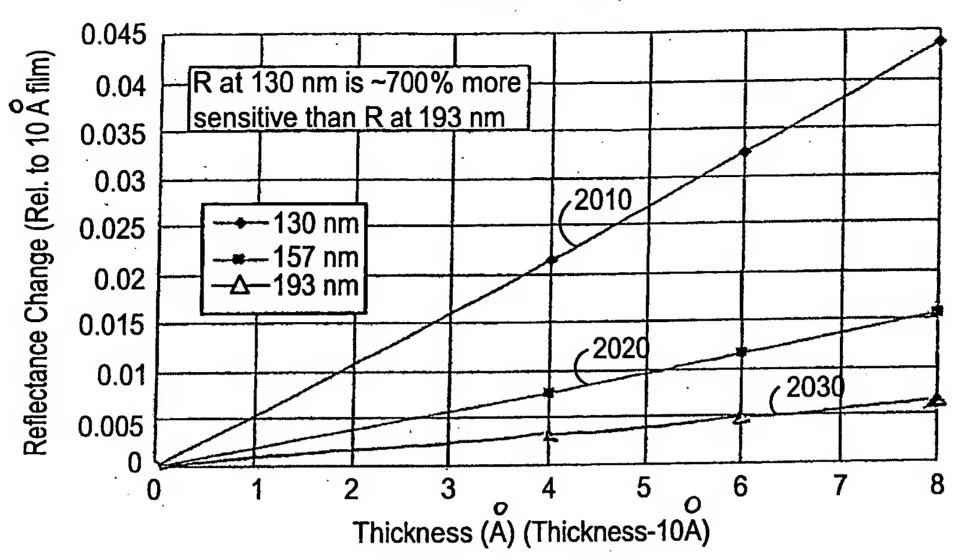


FIG. 20

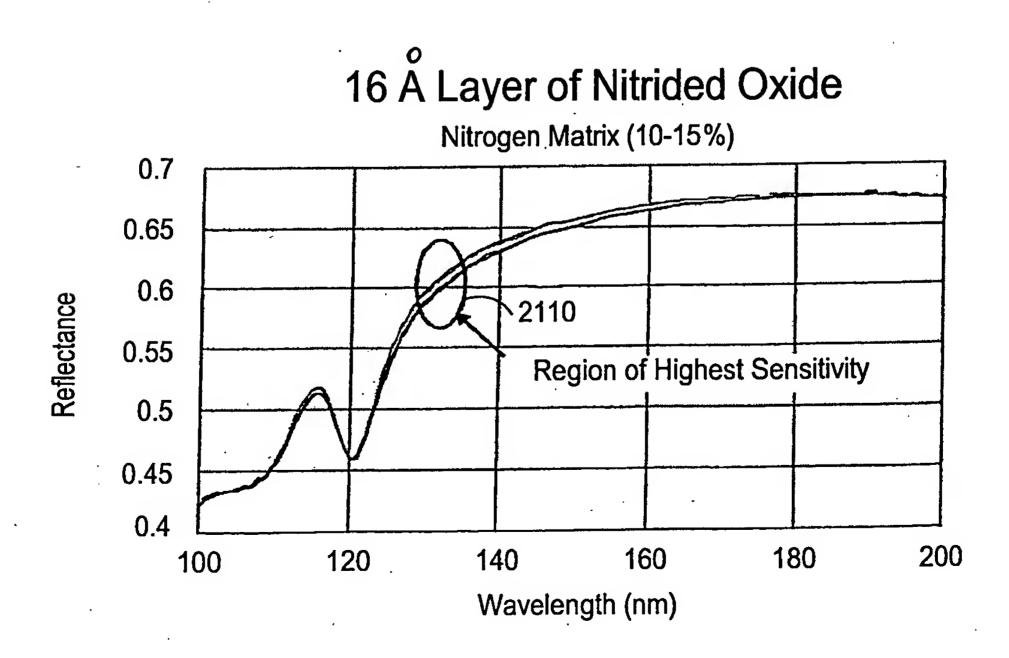


FIG. 21

16 Å Layer Nitrided Oxide

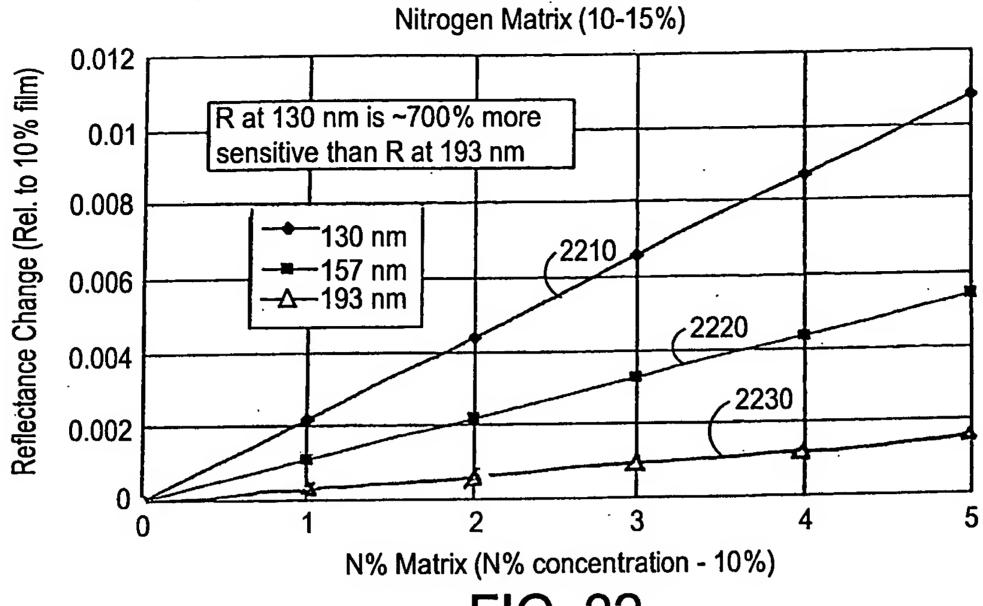


FIG. 22

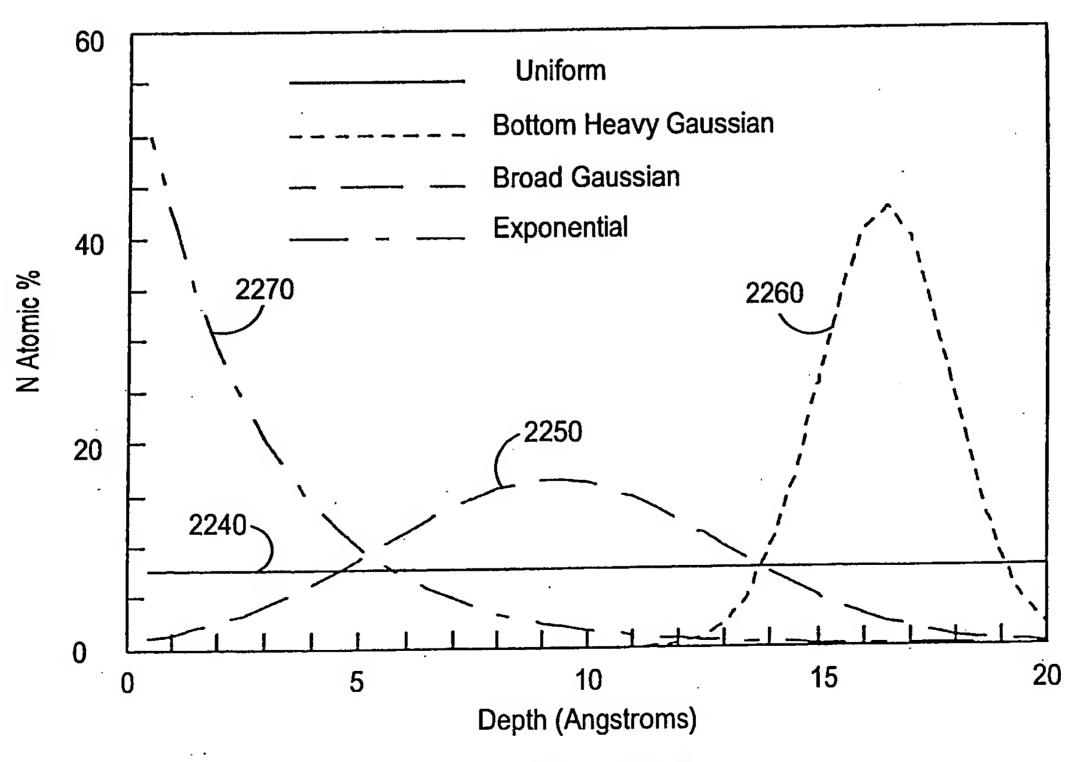


FIG. 22A

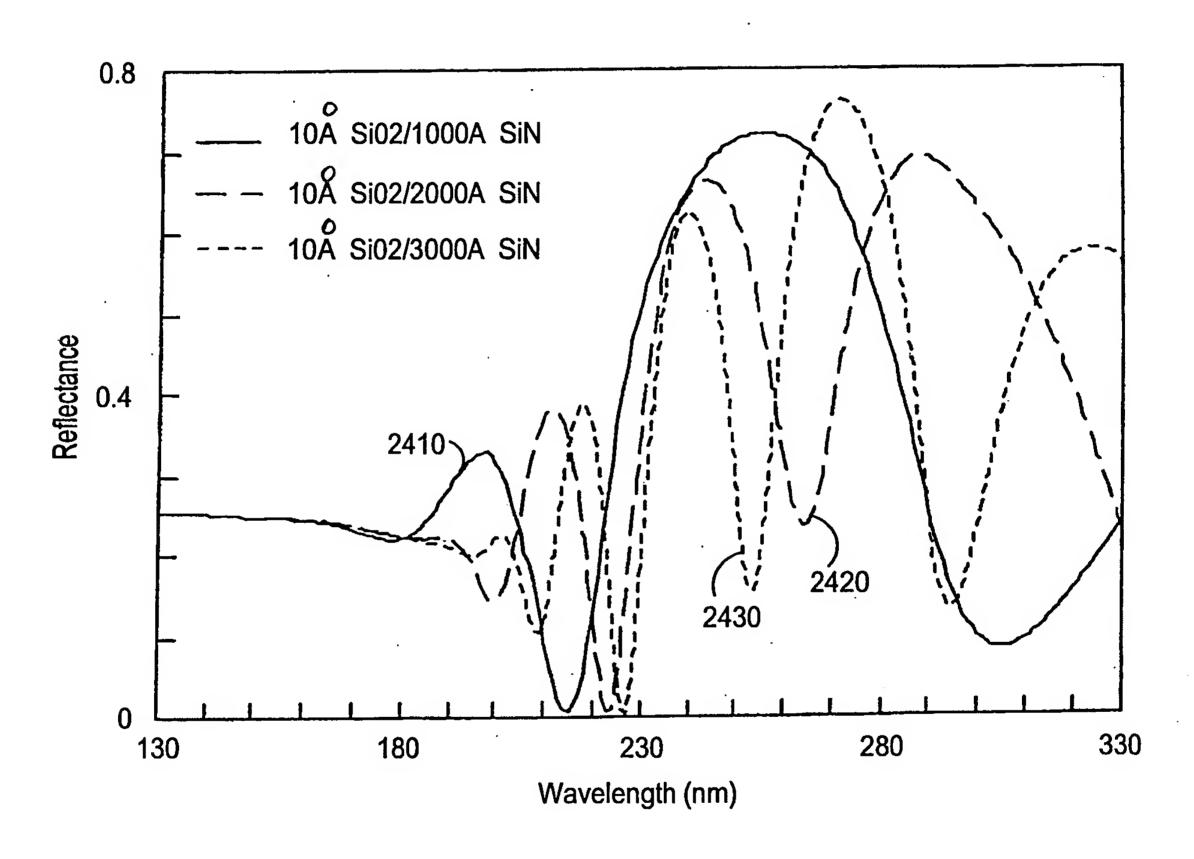


Fig. 24

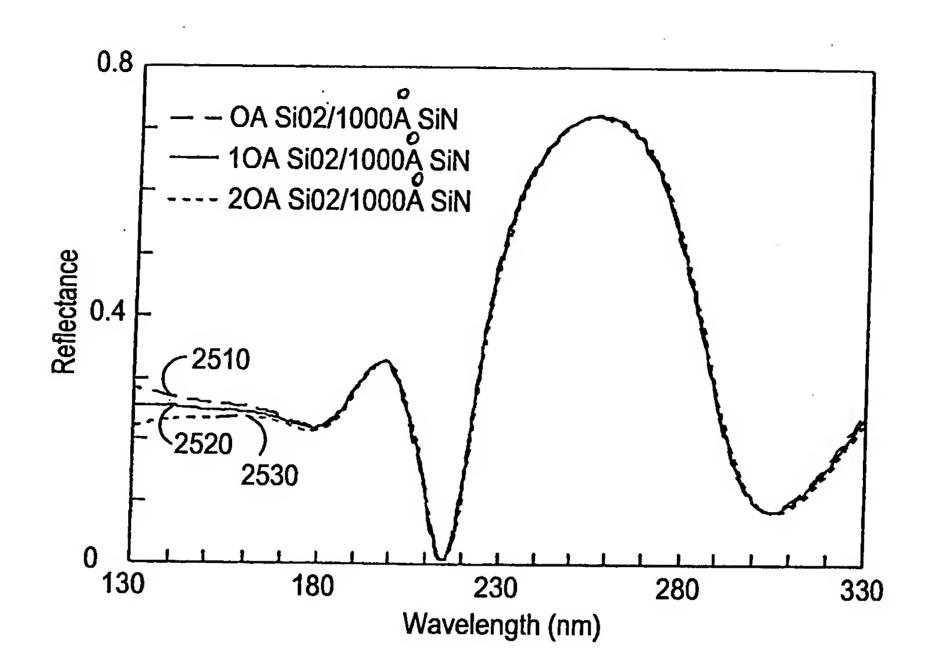


FIG. 25

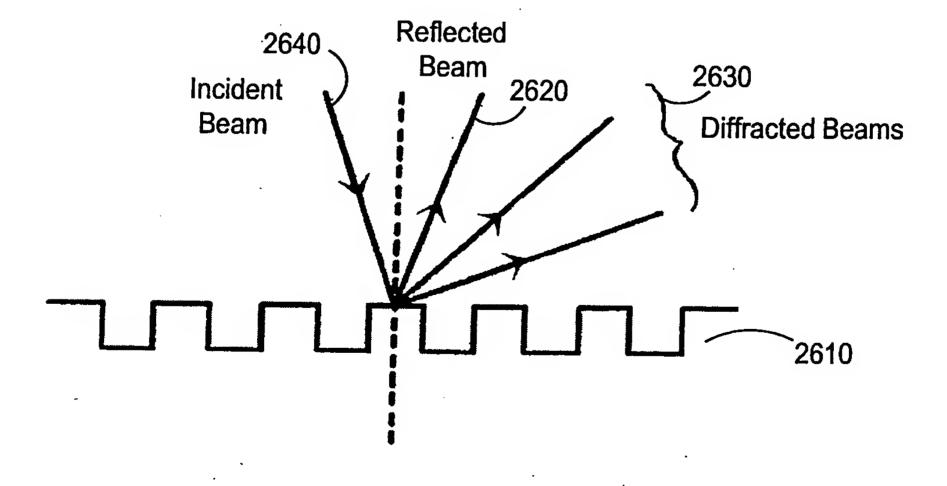
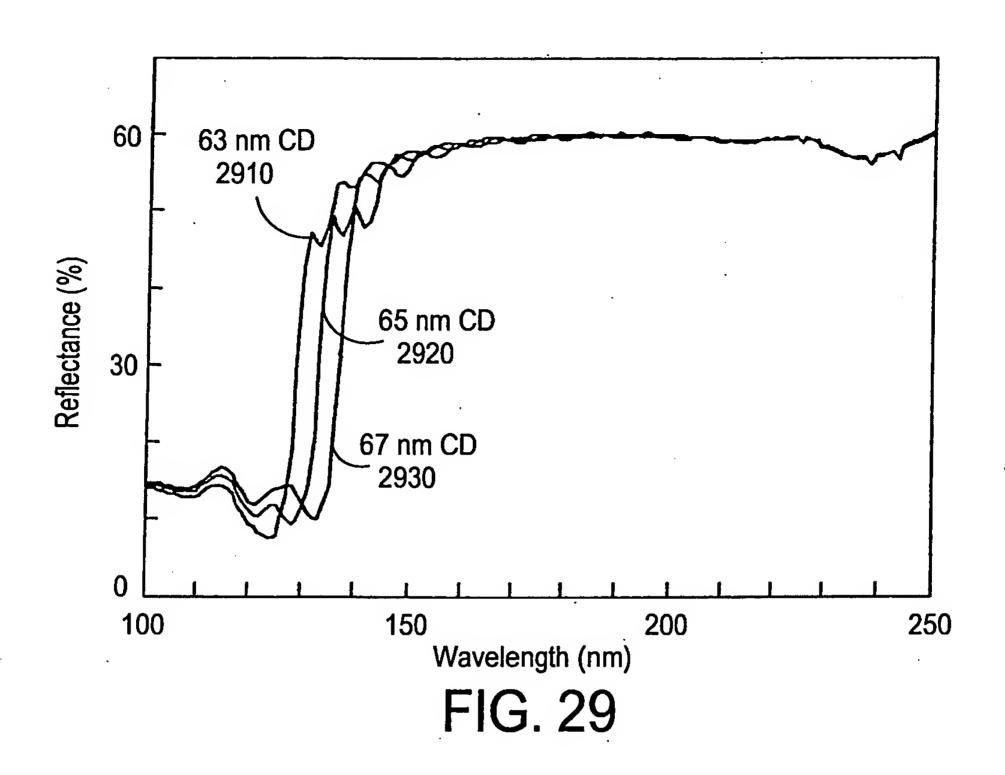


FIG. 26



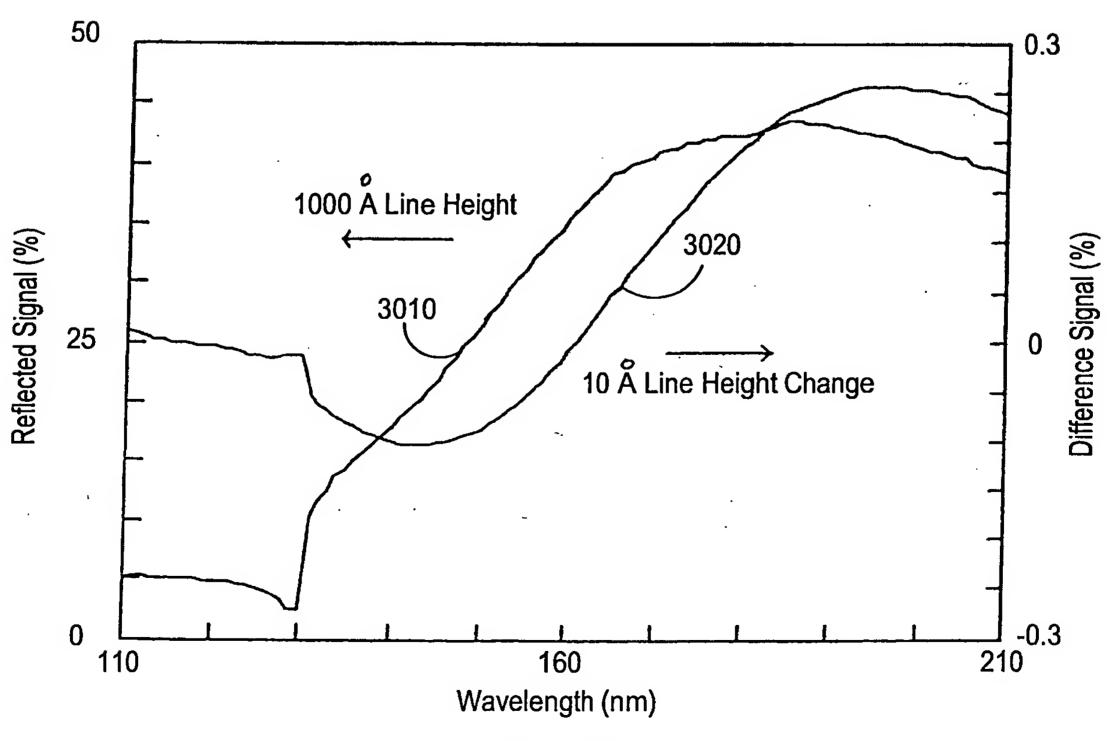


FIG. 30